

以化學水浴法沉積硫化鋅緩衝層特性之研究

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摘要

本研究以化學水浴沉積法成長ZnS緩衝層薄膜，藉由改變其製程，由傳統的一階段CBD製程為熱力學平衡下反應的過程，因此整個過程相當廢時。在反應溶液內產生均質成核的情況相當嚴重，易影響ZnS與基板結合的平整性，且在反應結束後，易有ZnS顆粒吸附於緩衝層薄膜上方，造成結構鬆散，薄膜易脫落的現象。因此，改為兩階段CBD製程，將玻璃基板浸泡再反應溶液1小時後再將基板放至另一玻璃反應溶液，使基板在一新的環境下進璃反應，希望藉由改變製程的因素，得到更優異的CBD緩衝層薄膜，並探討其薄膜之表面形貌及光學性質，藉此得到理想的緩衝層薄膜。經由研究結果得知，以兩階段CBD製程的緩衝層膜膜，其薄膜批覆性、均勻性經由FE-SEM及AFM觀察，經由UV-vis可以得知其平均穿透度雖然略微下降，但其光學能隙帶由~3.4eV提升至~3.9eV。經由XPS可以得知，硫?有利於氧化鋅的形成，隨硫?濃度的增加Zn₂p_{3/2}的ZnS(1021.7V)峰值產生藍移至ZnO(1022.4eV)。

關鍵詞：硫酸鋅、化學水浴沉積法

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